



Standard Test Methods for Temperature Calibration of Dynamic Mechanical Analyzers¹

This standard is issued under the fixed designation E1867; the number immediately following the designation indicates the year of original adoption or, in the case of revision, the year of last revision. A number in parentheses indicates the year of last reapproval. A superscript epsilon (ϵ) indicates an editorial change since the last revision or reapproval.

1. Scope*

1.1 These test methods describes the temperature calibration of dynamic mechanical analyzers (DMA) from -100°C to 300°C .

1.2 The values stated in SI units are to be regarded as standard. No other units of measurement are included in this standard.

1.3 *This standard does not purport to address all of the safety concerns, if any, associated with its use. It is the responsibility of the user of this standard to establish appropriate safety and health practices and determine the applicability of regulatory limitations prior to use.* Specific precautionary statements are given in [Note 10](#).

2. Referenced Documents

2.1 *ASTM Standards:*²

[E473 Terminology Relating to Thermal Analysis and Rheology](#)

[E1142 Terminology Relating to Thermophysical Properties](#)

[E2161 Terminology Relating to Performance Validation in Thermal Analysis and Rheology](#)

3. Terminology

3.1 *Definitions:*

3.1.1 The technical terms used in these test methods are defined in Terminologies [E473](#), [E1142](#), and [E2161](#), including *dynamic mechanical analysis, frequency, stress, strain, and storage modulus*.

4. Summary of Test Method

4.1 In dynamic mechanical analysis, often large (for example, 1 to 10 g), low thermal conductivity test specimens are characterized while being mechanically supported using

¹ These test methods are under the jurisdiction of ASTM Committee E37 on Thermal Measurements and are the direct responsibility of Subcommittee E37.10 on Fundamental, Statistical and Mechanical Properties.

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² For referenced ASTM standards, visit the ASTM website, www.astm.org, or contact ASTM Customer Service at service@astm.org. For *Annual Book of ASTM Standards* volume information, refer to the standard's Document Summary page on the ASTM website.

high thermal conductivity materials, while a temperature sensor is free-floating in the atmosphere near the test specimen. Under temperature programming conditions, where the atmosphere surrounding the test specimen is heated or cooled at rates up to $5^{\circ}\text{C}/\text{min}$, the temperature of the test specimen may lead or lag that of the nearby temperature sensor. It is the purpose of this standard to calibrate the dynamic mechanical analyzer temperature sensor so that the indicated temperature more closely approximates that of the test specimen. This is accomplished by separating the test specimen from its mechanical supports and from the surrounding atmosphere using a low thermal conductivity material. Three test methods of providing this separation are provided.

4.2 An equation is developed for the linear correlation of experimentally observed program or sensor temperature and the actual melting temperature for known melting reference materials. This is accomplished in Method A by a melting point reference materials loaded into a polymer tube, or in Method B by wrapping the calibration material with polymer tape or in Method C by placing the calibration material between glass or ceramic plates and subjecting this test specimen to a mechanical oscillation at either fixed or resonant frequency. The extrapolated onset of melting is identified by a rapid decrease in the ordinate signal (the apparent storage modulus, stress, inverse strain or probe position). This onset is used for temperature calibration with two melting point reference materials.

5. Significance and Use

5.1 Dynamic mechanical analyzers monitor changes in the viscoelastic properties of a material as a function of temperature and frequency, providing a means to quantify these changes. In most cases, the value to be assigned is the temperature of the transition (or event) under study. Therefore, the temperature axis (abscissa) of all DMA thermal curves must be accurately calibrated by adjusting the apparent temperature scale to match the actual temperature over the temperature range of interest.

6. Interferences

6.1 An increase or decrease in heating rates or change in purge gas type or rate from those specified may alter results.

6.2 Once the temperature calibration procedure has been executed, the measuring temperature sensor position shall not

*A Summary of Changes section appears at the end of this standard

be changed, nor shall it be in contact with the specimen or specimen holder in a way that would impede movement. If the temperature sensor position is changed or is replaced, then the entire calibration procedure shall be repeated.

6.3 Once the temperature calibration has been executed, the geometry deformation (bending study, versus tensile, and the like) shall not be changed. If the specimen testing geometry differs significantly from that of the calibrants, then the calibration shall be repeated in the geometry matching that of specimen testing.

6.4 These test methods do not apply to calibration for shear or compressive geometries of deformation.

7. Apparatus

7.1 The function of the apparatus is to hold a specimen of uniform dimension so that the specimen acts as the elastic and dissipative element in a mechanically oscillated system. Dynamic mechanic analyzers typically operate in one of several modes as outlined in **Table 1**.

7.1.1 The apparatus shall consist of the following:

7.1.1.1 *Clamps*—A clamping arrangement that permits gripping of the specimen. This may be accomplished by clamping at both ends (most systems), one end (for example, torsional pendulum) or neither end (for example, free bending between knife edges).

7.1.1.2 *Device to Apply Oscillatory Stress or Strain*—A device for applying an oscillatory deformation (strain) or oscillatory stress to the specimen. The deformation may be applied and then released, as in freely vibrating devices, or continually applied, as in forced vibration devices.

7.1.1.3 *Detector*—A device or devices for determining the dependent and independent experimental parameters, such as force (stress), deformation (strain), frequency, and temperature. Temperature shall be measurable with an accuracy of $\pm 0.1^\circ\text{C}$, force to $\pm 1\%$ and frequency to $\pm 1\%$.

7.1.1.4 *Temperature Controller and Oven*—A device for controlling the specimen temperature, either by heating, cooling (in steps or ramps), or by maintaining a constant experimental environment. The temperature programmer shall be sufficiently stable to permit measurement of specimen temperature to 0.1°C .

7.1.1.5 A *Data Collection Device*, to provide a means of acquiring, storing, and displaying measured or calculated signals, or both. The minimum output signals required for dynamic mechanical analysis are storage modulus, loss modulus, tangent delta, temperature, and time.

TABLE 1 Dynamic Mechanical Analyzer Modes of Operation

Mode	Mechanical Response			
	Tension	Flexural	Torsion	Compression
Free/dec ^A	X	...
Forced/res/CA ^A	...	X	X	...
Forced/fix/CA ^A	X	X	X	X
Forced/fix/CS ^A	X	X	...	X

^A Free = free oscillation; dec = decaying amplitude; forced = forced oscillation; CA = constant amplitude; res = resonant frequency; fix = fixed frequency; CS = controlled stress.

NOTE 1—Some instruments, suitable for this test, may display only linear or logarithmic storage modulus while others may display linear or logarithmic storage modulus, or both. Care must be taken to use the same modulus scale when comparing unknown specimens, and in the comparison of results from one instrument to another.

7.2 For Method A, high-temperature polymer tubing such as *PTFE (Polytetrafluoroethylene)* or *PEEK (Polyetheretherketone)*, of 3-mm outside diameter and wall thickness of 0.5-mm (0.002 in.) **(1)**³ may be used for low temperature standards (that is, less than 160°C). The tubing may be sealed with suitable melting temperature wax plugs, or similar sealant. (See **Appendix X3**.)

NOTE 2—PTFE tubing is selected for its flexibility and inert nature for the solvents in use at the temperatures of interest. Furthermore its transitions should not produce any interference in the DMA signal within the range of the suggested calibrant materials. PEEK provides increased stiffness for ease of loading. For other temperature ranges, a suitable replacement for the high temperature polymer tubing may be used.

7.3 For Method B, PTFE tape, to be used for wrapping metal point standards.

7.4 For Method C, sheet stock or coupons composed of one of the materials in **Table 3**, approximately 0.5 mm in thickness, and length and width similar to that of an unknown test specimen to be used.

7.5 *Calibration Materials*—One or more suitable materials presented in **Table 2**.

7.6 *Calipers* or other length measuring device capable of measuring dimensions (or length) within $\pm 10\ \mu\text{m}$.

8. Reagents and Materials

8.1 Dry nitrogen, helium, or other inert gas supplied for purging purposes and especially to ensure that moisture condensation and ice formation is avoided when measurements involve temperatures below the dew point.

9. Calibration and Standardization

9.1 Prepare the instrument for operation as described by the manufacturer in the operations manual.

³ The boldface numbers in parentheses refer to a list of references at the end of this standard.

TABLE 2 Calibration Materials

Material	Transition Temperature ^A		Reference
	°C	K	
<i>n</i> -Heptane	-90.56	182.65	X1.2
Cyclohexane	-87.06	186.09	X1.3
<i>n</i> -Octane	-56.76	216.39	X1.1
<i>n</i> -Decane	-26.66	246.49	X1.1
<i>n</i> -Dodecane	-9.65	263.5	X1.1
Water	0.01	273.16	X1.4
Cyclohexane	6.54	279.69	X1.3
Indium	156.5985	495.7485	X1.4
Tin	231.928	505.078	X1.4

^A The values in this table were determined under special, highly accurate test conditions that are not attainable or applicable to these test methods. The actual precision of these test methods is given in Section 13.

TABLE 3 Insulating Sheet Stock

Material	Thermal Conductivity at 25°C, W/(m·K)	Reference	Room Temperature Thermal Diffusivity at 25 °C, mm ² /s	Maximum Temperature, °C
Polytetrafluoroethylene	0.25	(2)		260 (2)
Polyimide	0.12	(3)		
	0.35 ^C			
Polyetheretherketone	0.25	(4)		400 (4)
Macor ^A	1.46		0.84	
			0.73	
Soda Lime Glass	0.94		0.51	250
Pyrex ^B Glass	1.45	(5)		

^A Macor is a registered trademark of Corning, Inc., Corning, NY.

^B Pyrex is a registered trademark of Corning, Inc., Corning, NY.

^C At 40°C.

10. Procedure

10.1 Two Point Calibration—For the purposes of this procedure, it is assumed that the relationship between observed extrapolated onset temperature (*T_o*) and actual specimen temperature (*T_i*) is a linear one governed by the equation:

$$T_i = (T_o \times S) + I \tag{1}$$

where: *S* and *I* are the slope and intercept of a straight line, respectively.

10.2 Select two calibration standards near the temperature range of interest. The standards should be as close to the upper and lower temperature limits used for the subsequent test materials as practical.

NOTE 3—The purpose of the polymer encapsulation is to provide thermal resistance between the test specimen and the environment similar to that offered by polymer test specimens. In some testing geometries it may be possible to perform the test directly on the metal melting point

reference materials without encapsulation. (See Appendix X2.)

10.3 Method A—Calibration Using Materials that are Liquids at Ambient Temperature and where the melting temperature does not exceed 100°C. (See Appendix X3.)

10.3.1 Fill the polymer tubing with the calibration material. Calibrant must extend to the ends of the clamping geometry and must have uniform dimensions with respect to width.

10.3.2 Mount the specimen in accordance with the procedure recommended by the manufacturer.

NOTE 4—For specimen clamping arrangements where the specimen is not gripped on either end (for example, free bending between knife edges) the specimen must be rigid enough at the test start temperature to sustain initial loading. Alternatively, the calibration specimen, without encapsulation, can be placed between the knife edge and a substrate.

10.3.3 Maximum strain amplitude shall be within the linear viscoelastic range of the specimens to be subsequently analyzed. Strains of less than 1 % are recommended and shall not exceed 3 %.

10.3.4 Conduct the calibration experiments at the heating rate of interest, preferably 1°C/min but no greater than 5°C/min and a frequency of 1 Hz. Other heating rates and frequencies may be used but shall be reported. (See Appendix X2.)

NOTE 5—Calibration for temperature shall be performed under the conditions of heating rate and frequency at which the unknown specimens will be tested. This test method does not address the issues of frequency affects for polymeric transitions (such as the upwards shift of glass transition temperature with increasing frequency), and will only compensate for thermal lag within the measuring device.

10.3.5 Measure and record the ordinate signal, from 30°C below to 20°C above the melting point of the reference material. The calibration specimen may be equilibrated a minimum of 50°C below the melting transition, but adequate time to achieve thermal equilibrium in the specimen must be allowed.

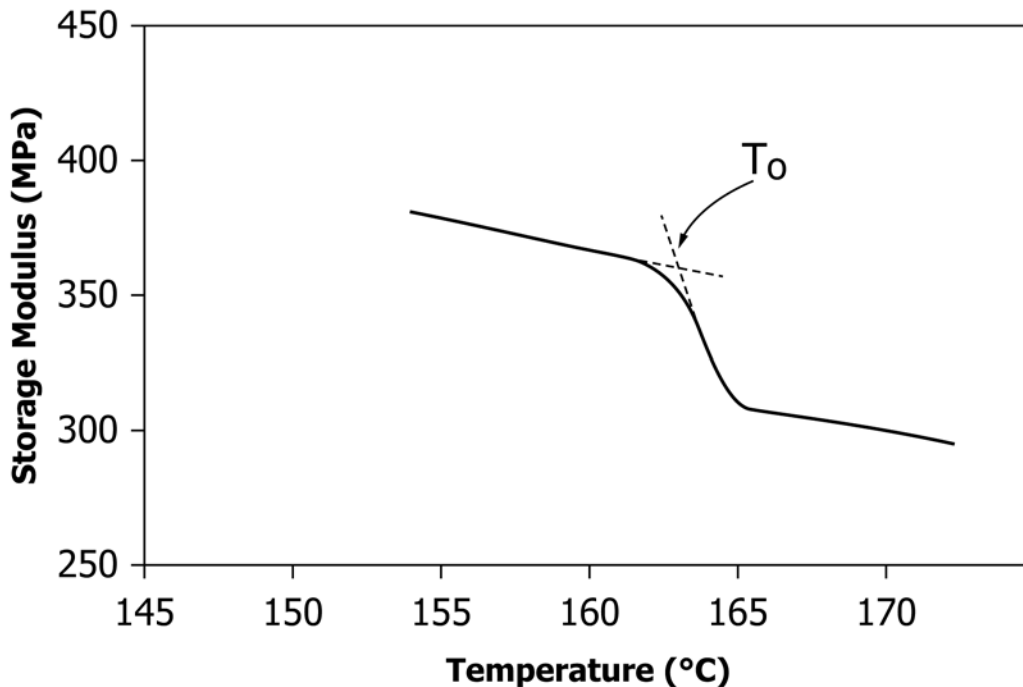


FIG. 1 Transition Temperature